January 2002

2.5A, 500V, 3.000 Ohm, N-Channel Power MOSFETs

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

Formerly developmental type TA17405.

Ordering Information

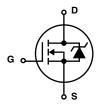
PART NUMBER	PACKAGE	BRAND
IRFR420	TO-252AA	IFR420
IRFU420	TO-251AA	IFU420

NOTE: When ordering, use the entire part number. Add the suffix T to obtain the TO-252AA variant in the tape and reel, i.e., IRFR420T.

Features

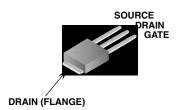
- 2.5A, 500V
- $r_{DS(ON)} = 3.000\Omega$
- Single Pulse Avalanche Energy Rated
- · SOA is Power Dissipation Limited
- · Nanosecond Switching Speeds
- Linear Transfer Characteristics
- · High Input Impedance
- · Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol

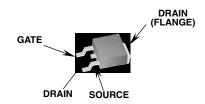


Packaging

JEDEC TO-251AA



JEDEC TO-252AA



IRFR420, IRFU420

Absolute Maximum Ratings $T_C = 25^{\circ}C$, Unless Otherwise Specified

	IRFR420, IRFU420	UNITS
Drain to Source Voltage (Note 1)	500	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1)	500	V
Continuous Drain Current	2.5	Α
$T_C = 100^{\circ}C$	1.6	Α
Pulsed Drain Current (Note 3)	8	Α
Gate to Source VoltageV _{GS}	±20	V
Maximum Power Dissipation	50	W
Linear Derating Factor	0.4	W/oC
Single Pulse Avalanche Energy Rating (Note 4)	210	mJ
Operating and Storage Temperature	-55 to 150	°C
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s	300	°C
Package Body for 10s, See Techbrief 334	260	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE

1. $T_J = 25^{\circ}C$ to $125^{\circ}C$.

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 250μA, V _{GS} = 0V (Figure 10)		-	-	V
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		-	4.0	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = Rated BV _{DSS} , V _{GS} = 0V		-	25	μА
		$V_{DS} = 0.8 \text{ x Rated BV}_{DSS}, V_{GS} = 0V, T_{J} = 125^{\circ}$	C -	-	250	μА
On-State Drain Current (Note 2)	I _{D(ON)}	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}, V_{GS} = 10V$	2.5	-	-	Α
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20V	-	-	±100	nA
Drain to Source On Resistance (Note 2)	r _{DS(ON)}	I _D = 1.3A, V _{GS} = 10V (Figures 8, 9)	-	2.9	3.0	Ω
Forward Transconductance (Note 2)	9fs	$V_{DS} \ge 10V$, $I_D = 2.0A$ (Figure 12)	1.5	2.2	-	S
Turn-On Delay Time	t _{d(ON)}	$V_{DD} = 250V$, $I_D \approx 2.5A$, $R_{GS} = 18\Omega$, $R_L = 100\Omega$,	-	10	15	ns
Rise Time	t _r	V _{GS} = 10V MOSFET Switching Times are Essentially	-	12	18	ns
Turn-Off Delay Time	t _d (OFF)	Independent of Operating Temperature	-	28	42	ns
Fall Time	t _f		-	12	18	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q _{g(TOT)}	V_{GS} = 10V, I_D = 2.5A, V_{DS} = 0.8 x Rated BV _{DSS} $I_{G(REF)}$ = 1.5mA (Figure 14) Gate Charge is Essentially Independent of Operating Temperature		13	19	nC
Gate to Source Charge	Q _{gs}			2.2	3.3	nC
Gate to Drain "Miller" Charge	Q _{gd}			6.8	10	nC
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz (Figure 11)		350	-	pF
Output Capacitance	C _{OSS}			54	-	pF
Reverse Transfer Capacitance	C _{RSS}			9.6	-	pF
Internal Drain Inductance	L _D	Measured From the Drain Lead, 6.0mm (0.25in) From Package to Center of Die Modified MOSFET Symbol Showing the Internal Device Inductances	-	4.5	-	nH
Internal Source Inductance	L _S	Measured From the Source Lead, 6.0mm (0.25in) From Package to Source Bonding Pad	-	7.5	-	nH
Thermal Resistance, Junction to Case	$R_{\theta JC}$		-	-	2.5	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	Mounted on FR-4 Board with Minimum Mounting pad	-	-	110	°C/W

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNITS
Continuous Source to Drain Current	I _{SD}	Modified MOSFET Symbol	-	-	2.5	Α
Pulse Source to Drain Current (Note 3)	I _{SDM}	Showing the Integral Reverse P-N Junction Rectifier		-	8	A
Source to Drain Diode Voltage (Note 2)	V _{SD}	$T_J = 25^{\circ}C$, $I_{SD} = 2.5A$, $V_{GS} = 0V$ (Figure 13)		-	1.6	V
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C$, $I_{SD} = 2.5A$, $dI_{SD}/dt = 100A/\mu s$		270	540	ns
Reverse Recovery Charge	Q _{RR}	$T_J = 25^{\circ}C$, $I_{SD} = 2.5A$, $dI_{SD}/dt = 100A/\mu s$		1.2	2.3	μС

NOTES:

- 2. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- 3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4. V_{DD} = 50V, starting T_J = 25°C, L = 60mH, R_G = 25 Ω , peak I_{AS} = 2.5A.

Typical Performance Curves Unless Otherwise Specified

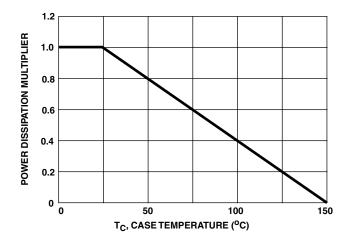


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

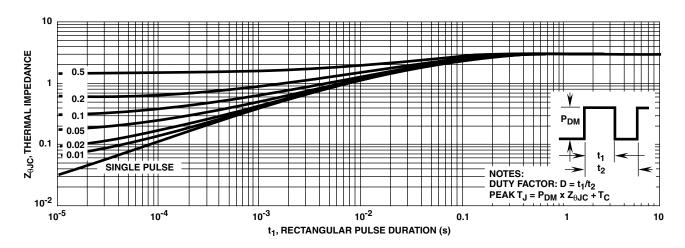


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

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Typical Performance Curves Unless Otherwise Specified (Continued)

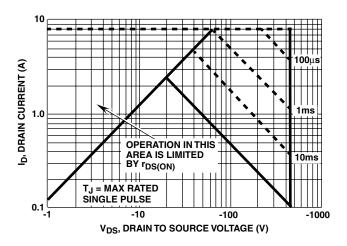


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

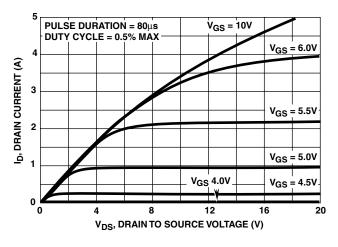


FIGURE 6. SATURATION CHARACTERISTICS

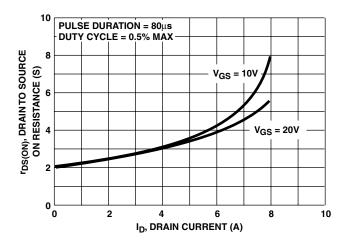


FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

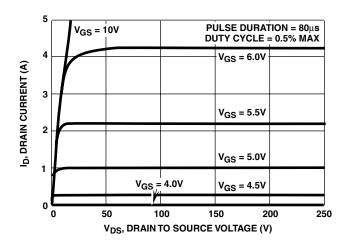


FIGURE 5. OUTPUT CHARACTERISTICS

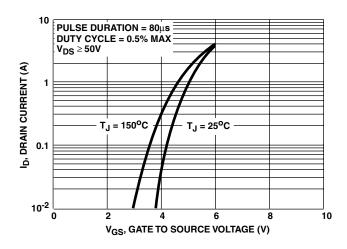


FIGURE 7. TRANSFER CHARACTERISTICS

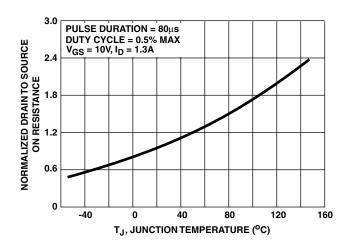


FIGURE 9. NORMALIZED DRAINTO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

Typical Performance Curves Unless Otherwise Specified (Continued)

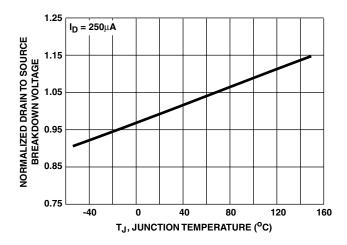


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

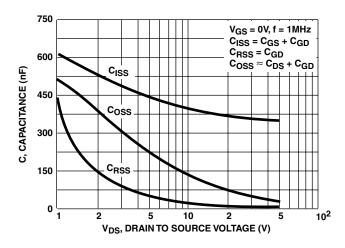


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

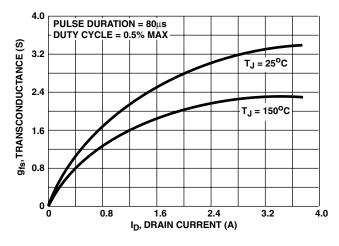


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

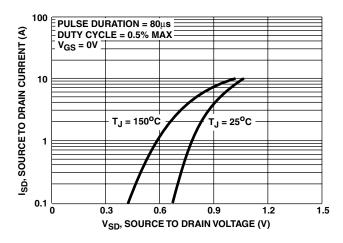


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

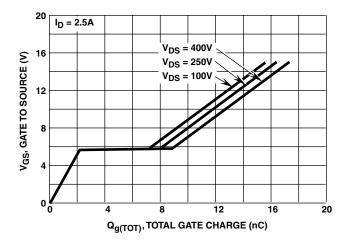


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

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Test Circuits and Waveforms

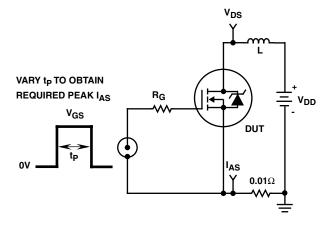


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

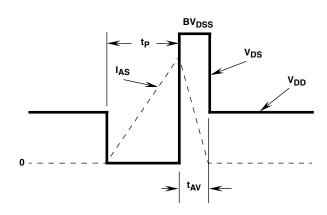


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

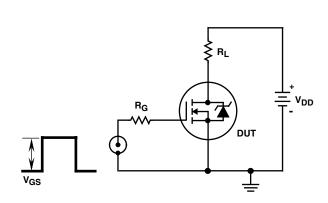


FIGURE 17. SWITCHING TIME TEST CIRCUIT

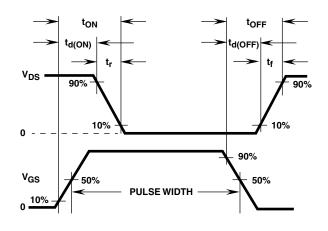


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

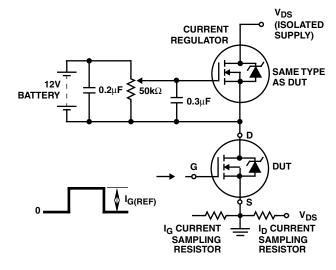


FIGURE 19. GATE CHARGE TEST CIRCUIT

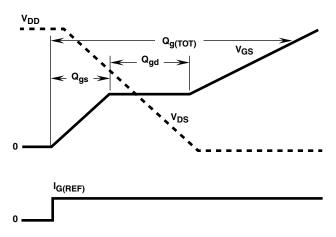


FIGURE 20. GATE CHARGE WAVEFORMS

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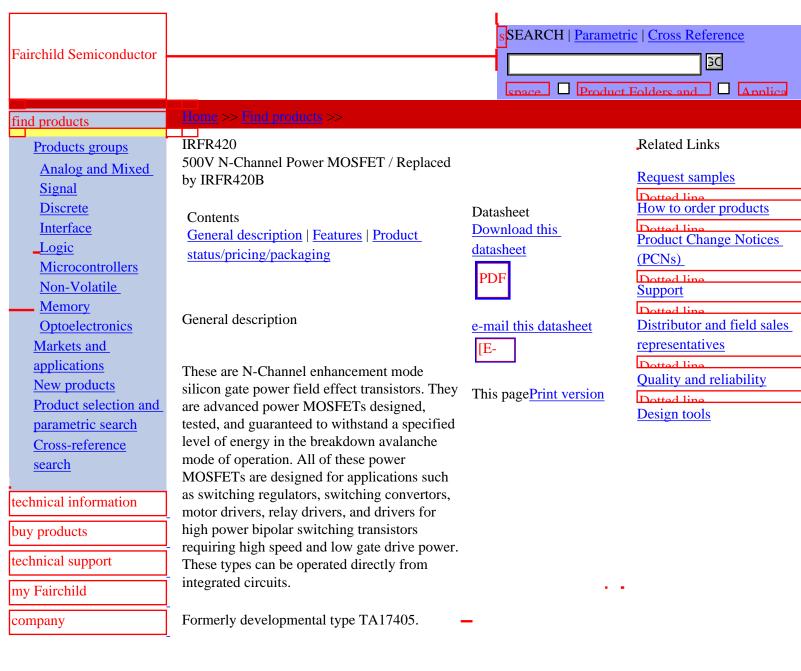
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- A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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Rev. H4



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Features

- 2.5A, 500V
- $r_{DS(ON)} = 3.000\Omega$
- Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

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Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
IRFR420TM	Lifetime Buy	\$0.71	TO-252(DPAK)	2	TAPE REEL

^{* 1,000} piece Budgetary Pricing

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